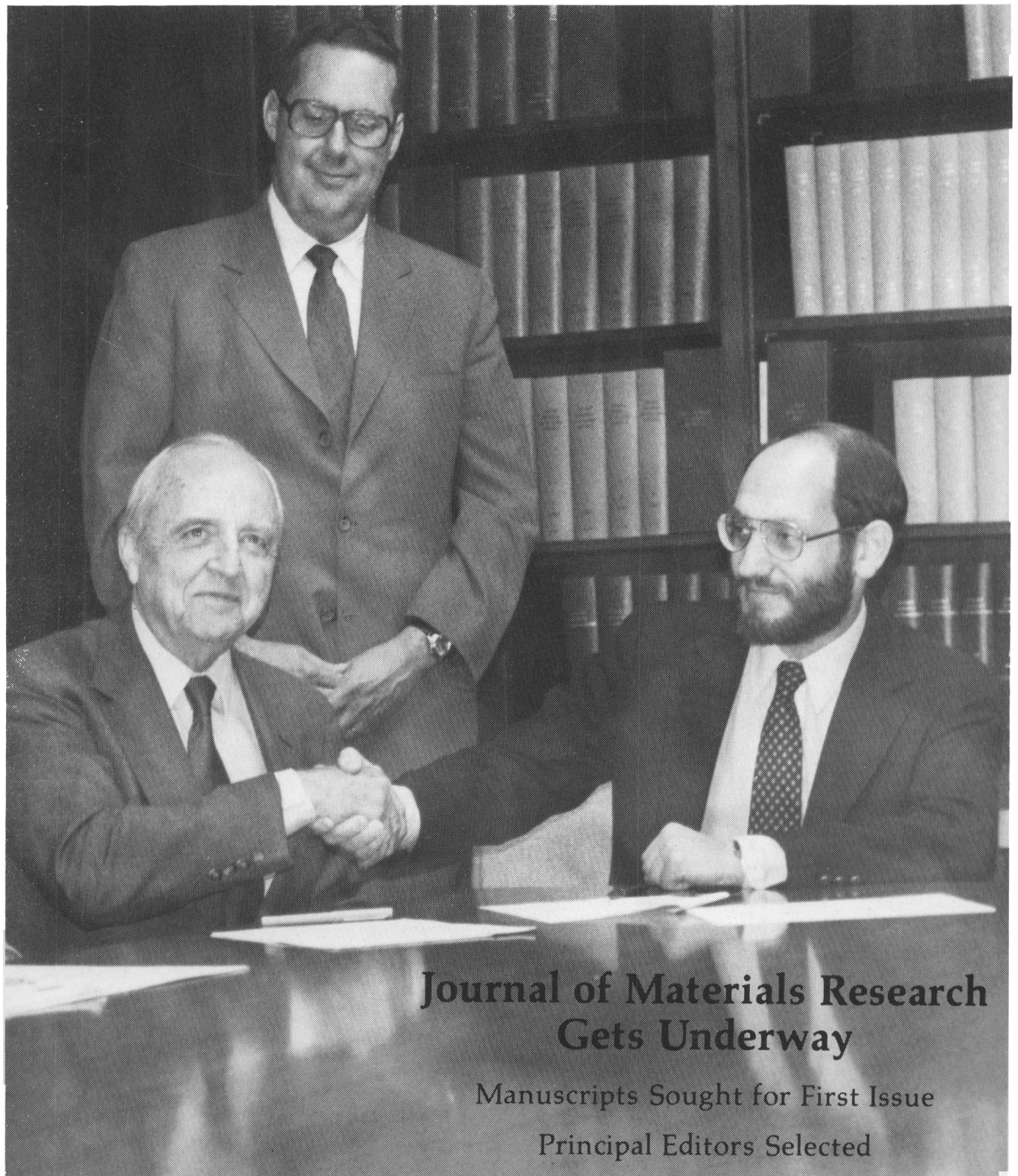


# MRS BULLETIN

*Materials Research Society*

*Vol. X No. 4*

*July/August 1985*



## **Journal of Materials Research Gets Underway**

**Manuscripts Sought for First Issue**

**Principal Editors Selected**

**ALSO: Candidate Profiles for 1986 MRS Elections**



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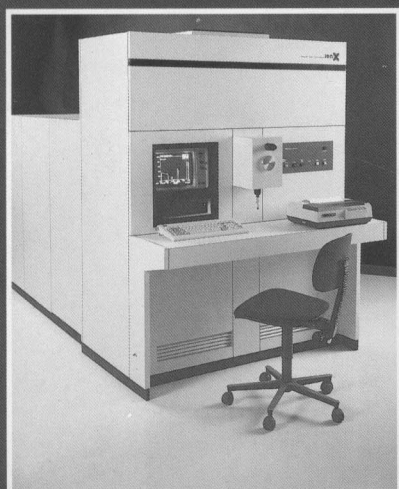
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